

<b>Issue Classification</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10757650	MAUPIN, PATRICK EVAN
	Examiner	Art Unit
	Flores, Leon	2611

Flores, Leon (Assistant Examiner)	7/18/2007 (Date)	<i>David Payne</i> DAVID C. PAYNE <del>SUPERVISORY PATENT EXAMINER</del>	Total Claims Allowed: 20		
(Legal Instruments Examiner)	(Date)	David C. Payne (Primary Examiner)	7/18/2007 (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 1